

Search Notes

Application/Control No.

10/659,060

Examiner

Marissa J. Detschel

Applicant(s)/Patent under
Reexamination

DE GROOT, PETER J.

Art Unit

2877

SEARCHED

Class	Subclass	Date	Examiner
356	503	9/20/2005	MJD
356	504	9/20/2005	MJD
356	505	9/20/2005	MJD
356	630	9/20/2005	MJD
356	632	9/20/2005	MJD
356	511	9/20/2005	MJD
356	512	9/20/2005	MJD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
356/503, 505, 504, 632, 512, and angle	9/20/2005	MJD
All of EAST for linnik adj interfer\$, scanning near inter\$ and angle, optical adj tomography and angle,	9/20/2005	MJD
inventors search for de Groot, Deck, and Fanton	9/20/2005	MJD
All of EAST for linnik and polariz\$, linnik and monochromatic, linnik and complex near reflectivity	9/21/2005	MJD
Search in various on-line encyclopedia and reference sources for "complex reflexivity"	9/20/2005	MJD
All of EAST for linnik and spatial near coherence, linnik and precalibrat\$, linnik and model and film, linnik and wavelength	9/22/2005	MJD